

## CERTIFICATE OF ACCREDITATION

## The ANSI National Accreditation Board

Hereby attests that

# Datacolor Technology (Suzhou) Co., Ltd 288 Shengpu Road Suzhou Jiangsu, China 215021

Fulfills the requirements of

ISO/IEC 17025:2017

In the field of

### **CALIBRATION**

This certificate is valid only when accompanied by a current scope of accreditation document. The current scope of accreditation can be verified at <a href="www.anab.org">www.anab.org</a>.

Jason Stine, Vice President

Expiry Date: 20 February 2027 Certificate Number: AC-1759









#### SCOPE OF ACCREDITATION TO ISO/IEC 17025:2017

#### Datacolor Technology (Suzhou) Co., Ltd

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#### CALIBRATION

Valid to: February 20, 2027 Certificate Number: AC-1759

#### **Photometry and Radiometry**

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-)	Reference Standard, Method, and/or Equipment
8°:t Geometry – Spectral Reflectance Factor	(1 to 100) %R (360 to 370) nm (380 to 390) nm (400 to 750) nm	0.54 %R 0.44 %R 0.38 %R	Comparison to CERAM Ceramic White Tile, M2009 Spectrometer, JJG 453-2002
8°:d Geometry - Spectral Reflectance Factor	(1 to 100) %R (360 to 370) nm (380 to 390) nm (400 to 750) nm	0.51 %R 0.43 %R 0.37 %R	Comparison to CERAM Ceramic White Tile, M2009 Spectrometer, JJG 453-2002
d:0° Geometry - Spectral Reflectance Factor	(1 to 100) %R (360 to 370) nm (380 to 700) nm	0.67 %R	Comparison to CERAM Ceramic White Tile, Elrepho Spectrometer, JJG 453-2002
Absolute 0°:45°- Bidirectional Spectral Reflectance Factor	(1 to 100) %R (400 to 410) nm (420 to 700) nm	0.87 %R 0.79 %R	Comparison to CERAM Ceramic White Tile, DC245 Spectrometer, JJG 453-2002

Calibration and Measurement Capability (CMC) is expressed in terms of the measurement parameter, measurement range, expanded uncertainty of measurement and reference standard, method, and/or equipment. The expanded uncertainty of measurement is expressed as the standard uncertainty of the measurement multiplied by a coverage factor of 2 (k=2), corresponding to a confidence level of approximately 95%.

#### Notes:

- 1. The uncertainty term R represents Spectral Reflectance.
- 2. This scope is formatted as part of a single document including Certificate of Accreditation No. AC-1759.

Jason Stine, Vice President

Version 012 Issued: January 19, 2025

